



PRODUCT DATA SHEET



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Datasheet

Samples

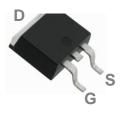
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.

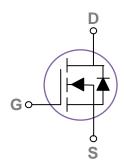


General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

TO252	Pin	Confid	uration





BVDSS	RDSON	ID
60V	50m $Ω$	16A

Features

- $60V,16A, RDS(ON) = 50m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Motor Drive
- Power Tools
- LED Lighting

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
	Drain Current – Continuous (T _C =25°C)	16	А
ID	Drain Current – Continuous (T _C =100°C)	10	Α
I _{DM}	Drain Current – Pulsed ¹	64	А
EAS	Single Pulse Avalanche Energy ²	11	mJ
IAS	Single Pulse Avalanche Current ²	15	А
D	Power Dissipation (T _C =25°C)	31	W
P_D	Power Dissipation – Derate above 25°C	0.25	W/°C
T _{STG}	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 150	°C

Thermal Characteristics

Symbol Parameter		Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case		4	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	nbol Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA		60			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.05		V/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =25°C			1	uA
		V _{DS} =48V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =8A		43	50	mΩ
		V_{GS} =4.5 V , I_D =4 A		50	60	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V I 050		1.8	2.5	V
$\triangle V_{GS(th)}$ $V_{GS(th)}$ Temperature Coefficient		-V _{GS} =V _{DS} , I _D =250uA		-4.2		mV/°C
gfs	Forward Transconductance	V_{DS} =10V , I_{D} =4A		6.5		S

Dynamic and switching Characteristics

_					
Q_g	Total Gate Charge ^{2, 3}		 14	21	
Q_{gs}	Gate-Source Charge ^{2,3} V _{DS} =48V , V _{GS} =10		 2.9	5	nC
Q_gd	Gate-Drain Charge ^{2, 3}		 2.3	4	
$T_{d(on)}$	Turn-On Delay Time ^{2,3}		 3.9	7	
Tr	Rise Time ^{2,3}	V_{DD} =30V , V_{GS} =10V , R_{G} =3.3 Ω	 12.6	24	ns
$T_{d(off)}$	Turn-Off Delay Time ^{2,3}	I _D =1A	 23.1	44	115
T_f	Fall Time ^{2,3}		 6.7	13	
C _{iss}	Input Capacitance		 800	1160	
Coss	Output Capacitance V _{DS} =15V , V _{GS} =0V , F=1MHz		 380	550	pF
C _{rss}	Reverse Transfer Capacitance		 115	170	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	 1.7	3.4	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V V OV Force Current			16	Α
I _{SM}	Pulsed Source Current	V _G =V _D =0V , Force Current			64	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- Repetitive Rating : Pulsed width limited by maximum junction temper
 V_{DD}=25V,V_{GS}=10V,L=0.1mH,I_{AS}=15A.,R_G=25Ω, Starting T_J=25°C
 The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
 Essentially independent of operating temperature.



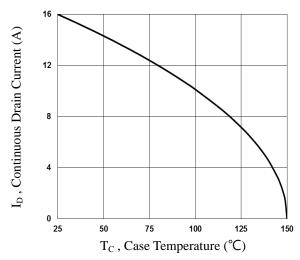


Fig.1 Continuous Drain Current vs. T_c

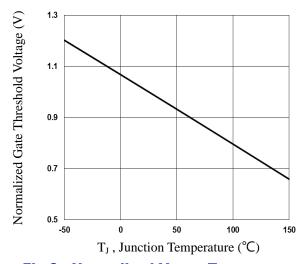


Fig.3 Normalized V_{th} vs. T_J

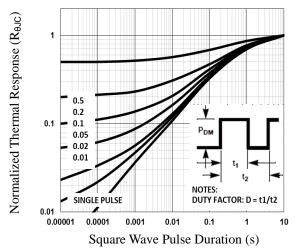


Fig.5 Normalized Transient Impedance

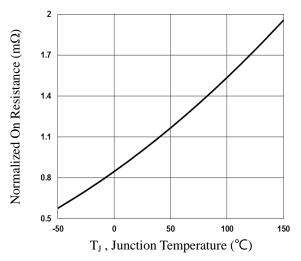


Fig.2 Normalized RDSON vs. T_J

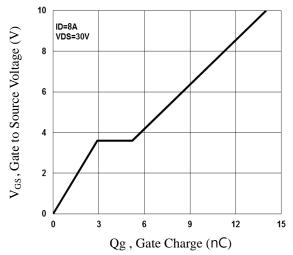


Fig.4 Gate Charge Waveform

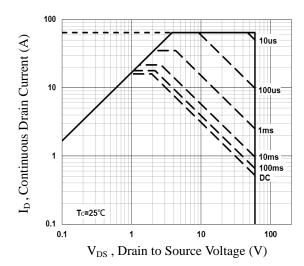


Fig.6 Maximum Safe Operation Area

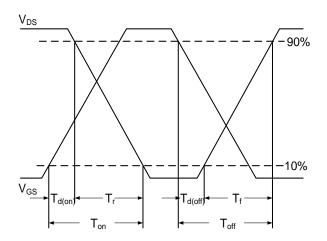


Fig.7 Switching Time Waveform

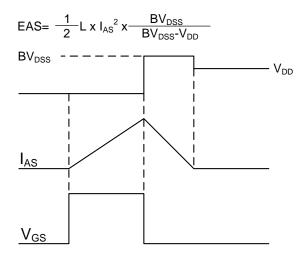
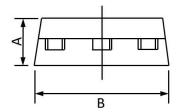
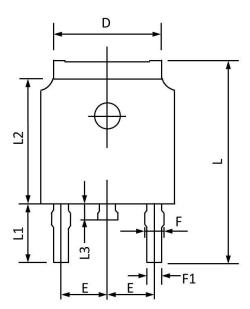


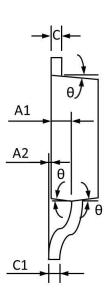
Fig.8 EAS Waveform



TO252 PACKAGE INFORMATION







Crush ol	Dimensions 1	In Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	2.20	2.40	0.087	0.094	
A1	0.91	1.11	0.036	0.044	
A2	0.00	0.15	0.000	0.006	
В	6.50	6.70	0.256	0.264	
C	0.46	0.580	0.018	0.230	
C1	0.46	0.580	0.018	0.030	
D	5.10	5.46	0.201	0.215	
E	2.186	2.386	0.086	0.094	
F	0.74	0.94	0.029	0.037	
F1	0.660	0.860	0.026	0.034	
L	9.80	10.40	0.386	0.409	
L1	2.9	REF	0.114	REF	
L2	6.00	6.20	0.236	0.244	
L3	0.60	1.00	0.024	0.039	
θ	3°	9°	3°	9°	



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